Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/636,100	SCHWARZ ET AL.
Examiner	Art Unit
Hwei-Siu C. Payer	3724

	SEARCHED		
Class	Subclass	Date	Examiner
search	rip dated	10-18-05	Payer

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAF	NOTES RCH STRATEGY	()
	DATE	EXMR